2.5V/3.3V 1:5 LVPECL **Fanout Buffer**

Description

The NB3L853141 is a low skew 1:5 LVPECL Clock fanout buffer designed explicitly for low output skew applications.

The NB3L853141 features a multiplexed input which can be driven by either a differential or single-ended input to allow for the distribution of a lower speed clock along with the high speed system clock.

The SEL pin will select the differential clock inputs, CLK0 & <u>CLKO</u>, when LOW (or left open and pulled LOW by the internal pull-down resistor). When SEL is HIGH, the single-ended CLK1 input is selected.

The common enable (\overline{EN}) is synchronous so that the outputs will only be enabled/disabled when they are already in the LOW state. This avoids any chance of generating a runt clock pulse when the device is enabled/disabled as can happen with an asynchronous control. The internal flip flop is clocked on the falling edge of the input clock, therefore, all associated specification limits are referenced to the negative edge of the clock input.

Features

- 700 MHz Maximum Clock Output Frequency
- CLK0 and CLK0 can Accept Differential LVPECL, LVDS, HCSL, LVHSTL, SSTL, LVCMOS
- CLK1 can Accept LVCMOS and LVTTL
- Five Differential LVPECL Clock Outputs
- 1.5 ns Maximum Propagation Delay
- Operating Range: $V_{CC} = 2.375 \text{ V}$ to 3.8 V
- LVCMOS Compatible Control Inputs
- Selectable Differential or LVCMOS Clock Inputs
- Synchronous Clock Enable
- 30 ps Max. Skew Between Outputs
- -40°C to +85°C Ambient Operating Temperature Range
- TSSOP-20 Package
- These are Pb-Free Devices

Applications

- Computing and Telecom
- Routers, Servers and Switches
- Backplanes

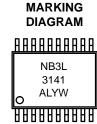


ON Semiconductor®

www.onsemi.com



CASE 948E



Α = Assembly Location

WL = Wafer Lot YY = Year WW = Work Week = Pb-Free Package

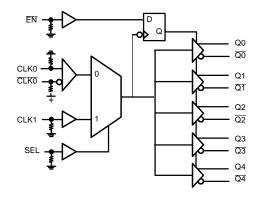
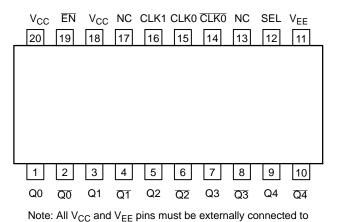


Figure 1. Simplified Logic Diagram of NB3L853141

ORDERING INFORMATION

See detailed ordering and shipping information on page 8 of this data sheet



Power Supply to guarantee proper operation.

Figure 1. Pinout (Top View) and Logic Diagram

Table 1. FUNCTION TABLE

| CLK0 | CLK1 | SEL | EN | Q |
|------|------|-----|----|----|
| L | Х | L | L | L |
| Н | X | L | L | Н |
| X | L | Н | L | L |
| X | Н | Н | L | Н |
| Х | Х | Х | Н | L* |

*On next negative transition of CLK0 or CLK1 X = Don't Care

Table 2. PIN DESCRIPTION

| Pin Number | Name | I/O | Open Default | Description |
|------------|------|-------------------------|-----------------|--|
| 1 | Q0 | LVPECL Output | | Non-Inverted Differential Clock Output |
| 2 | Q0 | LVPECL Output | | Inverted Differential Clock Output |
| 3 | Q1 | LVPECL Output | | Non-Inverted Differential Clock Output |
| 4 | Q1 | LVPECL Output | | Inverted Differential Clock Output |
| 5 | Q2 | LVPECL Output | | Non-Inverted Differential Clock Output |
| 6 | Q2 | LVPECL Output | | Inverted Differential Clock Output |
| 7 | Q3 | LVPECL Output | | Non-Inverted Differential Clock Output |
| 8 | Q3 | LVPECL Output | | Inverted Differential Clock Output |
| 9 | Q4 | LVPECL Output | | Non-Inverted Differential Clock Output |
| 10 | Q4 | LVPECL Output | | Inverted Differential Clock Output |
| 11 | VEE | Power | | Negative Supply Voltage |
| 12 | SEL | LVCMOS / LVTTL Input | Low | Clock Select Input. When HIGH, selects CLK1 input. When LOW, selects CLK0, CLK0 inputs. Internal Pull–down Resistor. |
| 13 | NC | | | No Connect |
| 14 | CLK0 | Multi-Level Input | High | Inverted Differential Clock Input. Internal Pull-up Resistor. |
| 15 | CLK0 | Multi-Level Input | Low | Non-Inverted Differential Clock Input. Internal Pull-down Resistor. |
| 16 | CLK1 | LVCMOS/LVTTL Input | Low | Single-ended Clock Input. Internal Pull-down Resistor. |
| 17 | NC | | | No Connect |
| 18 | VCC | Power | | Positive Supply Voltage |
| 19 | ĒN | LVCMOS/LVTTL Input | Low | Synchronous Clock Enable Input. When Low, outputs are enabled. When High, outputs are disabled Low. Internal Pull–down Resistor. |
| 20 | VCC | Power | | Positive Supply Voltage |

All VCC and VEE pins must be externally connected to a power supply to guarantee proper operation. Bypass each supply pin with 0.01 μ F to GND.

Table 3. ATTRIBUTES (Note 1)

| Characteris | Value | | | |
|--|---------------------------|-------------------|--|--|
| ESD Protection Human Body Model Machine Model | | > 2 kV > 200 V | | |
| R _{PU} – Pull–up Resistor | | 50 kΩ | | |
| R _{PD} – Pull–down Resistor | | 50 kΩ | | |
| Moisture Sensitivity (Note 1) | TSSOP-20 | Level 1 | | |
| Flammability Rating | UL*94 code V*0 @ 0.125 in | | | |
| Transistor Count | 300 | | | |
| Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test | | | | |

^{1.} For additional information, see Application Note AND8003/D.

Table 4. MAXIMUM RATINGS

| Symbol | Parameter | Condition 1 | Condition 2 | Rating | Unit |
|------------------|--|-----------------------|----------------------------------|-------------------------------|----------|
| V _{CC} | LVPECL Mode Power Supply | V _{EE} = 0 V | | 4.6 | V |
| VI | LVPECL Mode Input Voltage | V _{EE} = 0 V | V _I ≤ V _{CC} | -0.5 to V _{CC} + 0.5 | V |
| I _{out} | Output Current | Continuous Surge | | 50 100 | mA mA |
| T _A | Operating Temperature Range | | | -40 to +85 | °C |
| T _{stg} | Storage Temperature Range | | | -65 to +150 | °C |
| θ_{JA} | Thermal Resistance (Junction-to-Ambient) | 0 lfpm 500 lfpm | TSSOP-20 TSSOP-20 | 140 50 | °C/W |
| θ_{JC} | Thermal Resistance (Junction-to-Case) | Standard Board | TSSOP-20 | 23 to 41 | °C/W |
| T _{sol} | Wave Solder | <2 to 3 sec @ 260°C | | 265 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 5. DC CHARACTERISTICS $V_{CC} = 2.375 \text{ V}$ to 3.8 V; $V_{EE} = 0 \text{ V}$ (Note 2); $T_A = -40 ^{\circ}\text{C}$ to +85 $^{\circ}\text{C}$

| Symbol | Characterist | ic | Min | Тур | Max | Unit |
|--------------------|---|---|----------------------|-----|--|------|
| POWER SI | UPPLY | | • | | • | |
| V _{CC} | Power Supply Voltage | | 2.375 | | 3.8 | V |
| I _{EE} | Power Supply Current (Outputs Open) | | | 40 | 55 | mA |
| LVPECL O | UTPUTS (Note 3) | | | | | |
| V _{OH} | Output HIGH Voltage | | V _{CC} -1.4 | | V _{CC} -0.9 | V |
| V _{OL} | Output LOW Voltage | | V _{CC} -2.0 | | V _{CC} -1.7 | V |
| V _{SWING} | Output Voltage Swing, Peak-to-Peak | | 0.6 | | 1.0 | V |
| DIFFEREN | TIAL INPUTS DRIVEN SINGLE-ENDED (| Note 4) (Figures 3 and 4) | | | | |
| V _{IH} | Single-ended Input HIGH Voltage | | 0.5 | | V _{CC} +0.3 | V |
| V _{IL} | Single-ended Input LOW Voltage | | -0.3 | | V _{CC} -1.0 | V |
| V_{th} | Input Threshold Reference Voltage Rang | e (Note 5) | 0.35 | | V _{CC} -0.85 | V |
| V _{ISE} | Single-ended Input Voltage (V _{IH} - V _{IL}) | | 0.3 | | V _{CC} | V |
| DIFFEREN | TIAL INPUTS DRIVEN DIFFERENTIALLY | (see Figures 5 and 6) (Note 6) | | | | |
| V_{IHD} | Differential Input HIGH Voltage | | 0.5 | | V _{CC} -0.85 | mV |
| V_{ILD} | Differential Input LOW Voltage | | 0 | | V _{IHD} -150 | mV |
| V_{ID} | Differential Input Voltage (V _{IHD} – V _{ILD}) | | 0.15 | | 1.3 | V |
| V_{CMR} | Common Mode Input Voltage; (Note 7) | | 0.5 | | V _{CC} -0.85 | |
| I _{IH} | Input HIGH Current | $V_{CC} = V_{IN} = 3.8 \text{ V} \frac{\text{CLK0}}{\text{CLK0}}$ | | | 150 5 | μΑ |
| I _{IL} | Input LOW Current | $V_{CC} = 3.8V$, $V_{IN} = 0$ V $\frac{CLK0}{CLK0}$ | –5 –150 | | | μΑ |
| SINGLE-E | NDED INPUTS (SEL, EN, CLK1) | | | | | |
| V _{IH} | Input HIGH Voltage | SEL, <u>EN</u> CLK1 | 2.0 2.0 | | V _{CC} +0.3 V _{CC} +0.3 | V |
| V _{IL} | Input LOW Voltage | SEL, EN CLK1 | -0.3 -0.3 | | 0.8 V _{CC} x0.35 | V |
| I _{IH} | Input HIGH Current VCC = V _{IN} = 3.8 V | CLK1, SEL, EN | | | 150 | μΑ |
| I _{IL} | CLK1, SEL, EN | CLK1, SEL, EN | - 5 | | | μΑ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

- circuit board with maintained transverse airliow greater than 500 irpm.
 2. Input and Output parameters vary 1:1 with V_{CC} .
 3. LVPECL outputs loaded with 50 Ω to V_{CC} 2 V for proper operation.
 4. V_{th} , V_{IH} , V_{IL} , and V_{ISE} parameters must be complied with simultaneously.
 5. V_{th} is applied to the complementary input when operating in single—ended mode.
 6. V_{IHD} , V_{ILD} , V_{ID} and V_{CMR} parameters must be complied with simultaneously.
 7. The common mode voltage is defined as V_{IH} .

Table 6. AC CHARACTERISTICS, $V_{CC} = 2.375 \text{ V}$ to 3.8 V, $T_A = -40^{\circ}\text{C}$ to +85°C (Note 8)

| Symbol | Characteristic | Characteristic | | | | Max | Unit |
|--|---|--|---|------------|--|------------|------------|
| f _{MAX} | Maximum Input Clock Frequency: V _{OUTpp} ≥ 400 mV | CLK0/CL | K0, V _{INPPmin} ≥ 250 mV CLK1 | 700 300 | | | MHz |
| Φ_{N} | Phase Noise, f _C = 155.52 MHz | 10 Hz 100 Hz 1 kHz 10 kHz 100 kHz 1 MHz 10 MHz 20 MHz | Offset from Carrier | | -100.5 -128.2 -138.6 -147.1 -149.7 -154.2 -154.2 -154.2 | | dBc/ Hz |
| t _{PLH} , t _{PHL} | Propagation Delay to Differential Outputs, @ 50 MHz | Note 9 Note 10 | CLK0/CLK0 to Q/Q CLK1 to Q | 0.8 0.8 | 1.0 1.0 | 1.5 1.5 | ns |
| t∫⊕N | Additive Phase Jitter, RMS; f _C = 155.52 MHz, Integration Range: 12 kHz – 20 MHz | | | | 0.05 | | ps |
| tsk(o) | Output-to-output skew; (Note 11) | | | | | 30 | ps |
| tsk (pp) | Part-to-Part Skew; (Note 12) | | | | | 150 | ps |
| V_{INpp} | Input Voltage Swing/Sensitivity (Differential Configuration | ion) (Note 1 | 4) | 150 | | 1300 | mV |
| t _r /t _f | Output rise and fall times, 20% to 80%, | | Q, Q | 200 | | 700 | ps |
| ODC | Output Clock Duty Cycle CLK0/CLK0 Input Duty Cycle = 50% | 0, f ≤ 700 M | Hz, V _{INPPmin} ≥ 250 mV CLK1, f ≤ 250MHz | 45 45 | | 55 55 | % |

All parameters measured at f_{MAX} unless noted otherwise.

The cycle-to-cycle jitter on the input will equal the jitter on the

output. The part does not add jitter

^{8.} Measured using a $V_{INPPmin}$ source, Reference Duty Cycle = 50% duty cycle clock source. All output loading with external 50 Ω to $V_{CC}-2$ V.

Measured from the differential input crossing point to the differential output crossing point.
 Measured from V_{CC}/2 input crossing point to the differential output crossing point.

^{11.} Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at the output differential cross points.

^{12.} Defined as skew between outputs on different devices operating at the same supply voltages and with equal load conditions. Using the same type of inputs on each device, the outputs are measured at the differential cross points.

13. Output voltage swing is a single–ended measurement operating in differential mode.

^{14.} Input voltage swing is a single-ended measurement operating in differential mode.

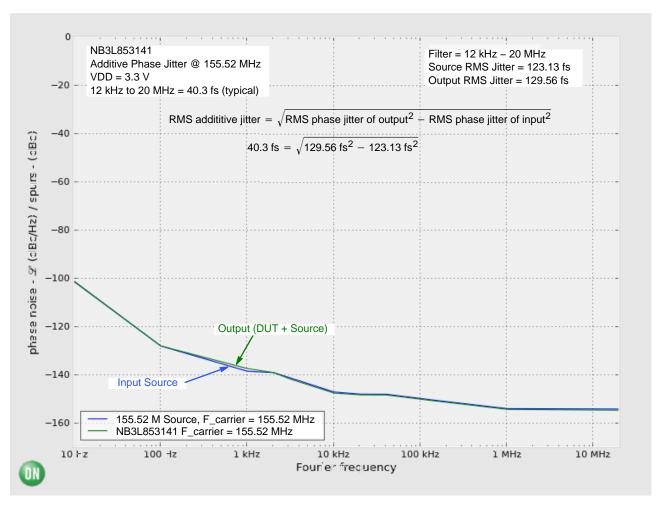


Figure 2. Typical Phase Noise Plot at f_{carrier} = 155.52 MHz at an Operating Voltage of 3.3 V, Room Temperature

The above phase noise data was captured using Agilent E5052A/B. The data displays the input phase noise and output phase noise used to calculate the additive phase jitter at a specified integration range. The RMS Phase Jitter contributed by the device (integrated between 12 kHz and 20 MHz) is 40.3 fs.

The additive phase jitter performance of the fanout buffer is highly dependent on the phase noise of the input source.

To obtain the most accurate additive phase noise measurement, it is vital that the source phase noise be

notably lower than that of the DUT. If the phase noise of the source is greater than the device under test output, the source noise will dominate the additive phase jitter calculation and lead to an artificially low result for the additive phase noise measurement within the integration range. The Figure above is a good example of the NB3L853141 source generator phase noise having a significantly higher floor such that the DUT output results in an additive phase jitter of 40.3 fs.

RMS addititive jitter =
$$\sqrt{\text{RMS phase jitter of output}^2 - \text{RMS phase jitter of input}^2}$$

 $40.3 \, \text{fs} = \sqrt{129.56 \, \text{fs}^2 - 123.13 \, \text{fs}^2}$

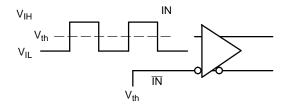


Figure 3. Differential Input Driven Single-Ended

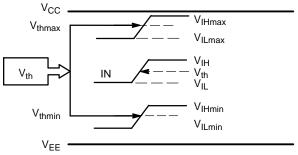


Figure 4. V_{th} Diagram

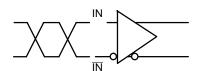
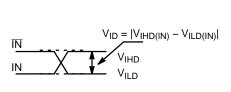


Figure 5. Differential Inputs Driven Differentially



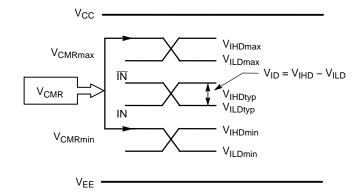


Figure 6. Differential Inputs Driven Differentially

Figure 7. VCMR Diagram

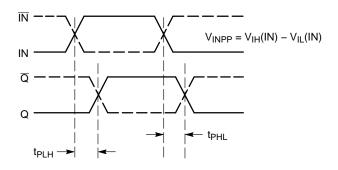


Figure 8. AC Reference Measurement

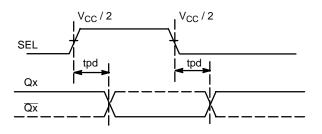


Figure 9. SEL to Qx Timing Diagram

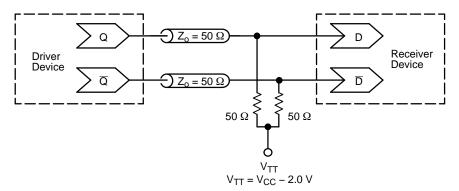


Figure 10. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8020/D – Termination of ECL Logic Devices.)

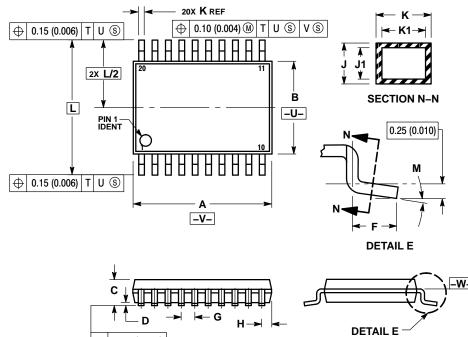
ORDERING INFORMATION

| Device | Package | Shipping [†] |
|-----------------|-----------------------|-----------------------|
| NB3L853141DTG | TSSOP-20 (Pb-Free) | 75 Units / Rail |
| NB3L853141DTR2G | TSSOP-20 (Pb-Free) | 2500 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

TSSOP-20 CASE 948E-02 **ISSUE C**



0.100 (0.004)

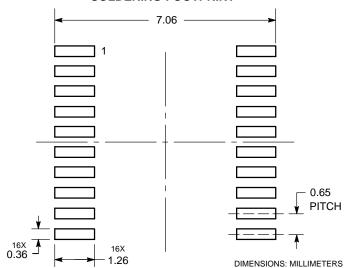
-T- SEATING PLANE

- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
- FLASH, PROTRUSIONS OR GATE BURRS.
 MOLD FLASH OR GATE BURRS SHALL NOT
 EXCEED 0.15 (0.006) PER SIDE.

 4. DIMENSION B DOES NOT INCLUDE
 INTERLEAD FLASH OR PROTRUSION.
 INTERLEAD FLASH OR PROTRUSION
 SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
 DIMENSION K DOES NOT INCLUDE
 DAMBAR PROTRUSION. ALLOWABLE
 DAMBAR PROTRUSION. SHALL BE 0.08
 (0.003) TOTAL IN EXCESS OF THE K
- (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
 TERMINAL NUMBERS ARE SHOWN FOR
- REFERENCE ONLY.
 DIMENSION A AND B ARE TO BE
 DETERMINED AT DATUM PLANE -W-.

| | MILLIMETERS | | INCHES | |
|-----|-------------|------|-----------|-------|
| DIM | MIN | MAX | MIN | MAX |
| Α | 6.40 | 6.60 | 0.252 | 0.260 |
| В | 4.30 | 4.50 | 0.169 | 0.177 |
| С | | 1.20 | | 0.047 |
| D | 0.05 | 0.15 | 0.002 | 0.006 |
| F | 0.50 | 0.75 | 0.020 | 0.030 |
| G | 0.65 | BSC | 0.026 BSC | |
| Н | 0.27 | 0.37 | 0.011 | 0.015 |
| 7 | 0.09 | 0.20 | 0.004 | 0.008 |
| J1 | 0.09 | 0.16 | 0.004 | 0.006 |
| K | 0.19 | 0.30 | 0.007 | 0.012 |
| K1 | 0.19 | 0.25 | 0.007 | 0.010 |
| L | 6.40 BSC | | 0.252 | BSC |
| M | 0° | 8° | 0° | 8° |

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and the are registered trademarks of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries. SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding t

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303–675–2175 or 800–344–3860 Toll Free USA/Canada Fax: 303–675–2176 or 800–344–3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800–282–9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81–3–5817–1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative